



Agilent Technologies

Sample ID:	Buist CBZ HI meoh	Method Name:	STUDENT ATR 32 4cm
Sample Scans:	32	User:	STUDENT
Background Scans:	32	Date/Time:	27/06/2014 11:39:21
Resolution:	4 cm ⁻¹	Range:	4,000.00 - 650.00
System Status:	Good	Apodization:	Happ-Genzel
File Location:	C:\Program Files\Agilent\MicroLab PC\Results\STUDENT ATR 32 4cm\2014-06-27T11-40-48.a2r		

